30NM65-F Power MOSFET

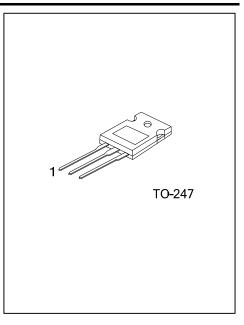
# 30A, 650V N-CHANNEL SUPER-JUNCTION MOSFET

#### **■** DESCRIPTION

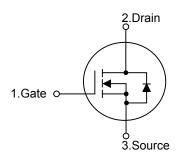
The **UTC 30NM65-F** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

### ■ FEATURES

- \*  $R_{DS(ON)}$  < 0.17 $\Omega$  @  $V_{GS}$ =10V,  $I_{D}$ =15A
- \* High Switching Speed
- \* 100% Avalanche Tested



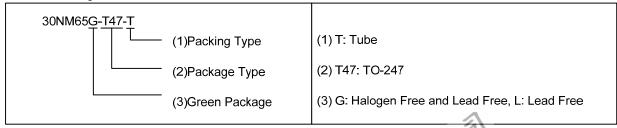
#### ■ SYMBOL



#### ORDERING INFORMATION

Ordering Number		Dooksaya	Pin Assignment			Deelsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
30NM65L-T47-T	30NM65G-T47-T	TO-247	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



# ■ MARKING



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# ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	650	V
Gate-Source Voltage		$V_{GSS}$	±30	V
Drain Current	Continuous	$I_D$	30	Α
	Pulsed (Note 2)	$I_{DM}$	90	Α
Avalanche Energy	valanche Energy Single Pulsed (Note 3)		910	mJ
Peak Diode Recovery dv/dt		dv/dt	10	V/ns
Power Dissipation		$P_{D}$	310	W
Junction Temperature		$T_J$	+150	°C
Storage Temperature		$T_{STG}$	-55 ~ <b>+</b> 150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L =58mH,  $I_{AS}$  = 5.6A,  $V_{DD}$  = 100V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C
- 4.  $I_{SD} \le 30A$ ,  $di/dt \le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$

#### THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	40	°C/W	
Junction to Case	$\theta_{JC}$	0.4	°C/W	

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C, unless otherwise specified)

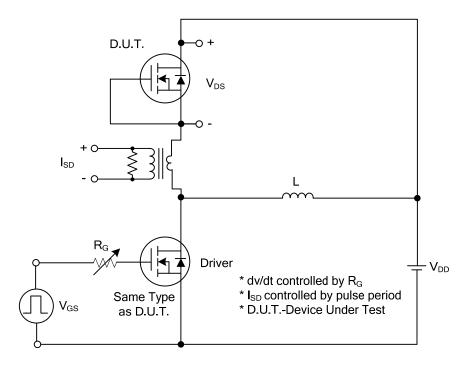
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		$BV_{DSS}$	$I_D = 250 \mu A, V_{GS} = 0 V$	650			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V			50	μΑ
Gate- Source Leakage Current	Forward		$V_{GS}$ =+30V, $V_{DS}$ =0V			+100	nA
	Reverse	$I_{GSS}$	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	2.5		4.5	V
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =15A			0.17	Ω
DYNAMIC PARAMETERS					_	_	
Input Capacitance		$C_{ISS}$			2550		pF
Output Capacitance		Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		1600		pF
Reverse Transfer Capacitance		C <sub>RSS</sub>			100		pF
SWITCHING PARAMETERS					_	_	
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$			32		ns
Rise Time		t <sub>R</sub>	$V_{DD}$ =150V, $I_{D}$ =20A, $R_{G}$ =25 $\Omega$ ,		25		ns
Turn-OFF Delay Time		t <sub>D(OFF)</sub>	V <sub>GS</sub> =10V (Note 1,2)		246		ns
Fall-Time		t <sub>F</sub>			96		ns
SOURCE- DRAIN DIODE RATIN	NGS AND CH	ARACTERIS	TICS				
Maximum Body-Diode Continuous Current		Is				30	Α
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>				90	Α
Drain-Source Diode Forward Voltage (Note 1)		$V_{SD}$	I <sub>S</sub> =30A, V <sub>GS</sub> =0V			1.4	V
Body Diode Reverse Recovery Time (Note 1)		t <sub>rr</sub>	Is=30A, V <sub>GS</sub> =0V.		320		ns
Body Diode Reverse Recovery Charge		Q <sub>rr</sub>	dl <sub>F</sub> /dt=100A/μs 3.8				μC

Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

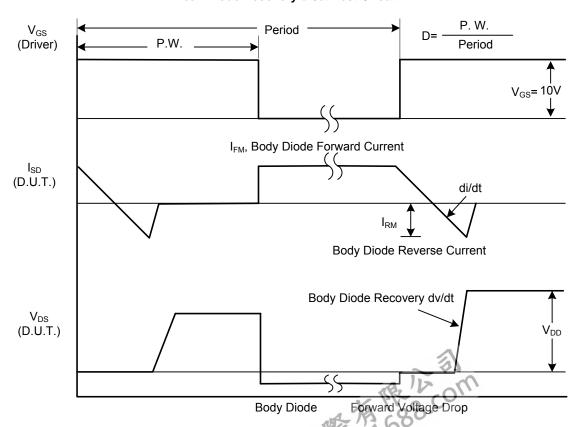
ruise rest: Pulse width ≤ 300μs, Duty cycle ≤ 2%.
Essentially independent of operating ambient temperature.



## **■ TEST CIRCUITS AND WAVEFORMS**



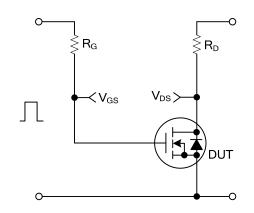
# Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

30NM65-F **Power MOSFET** 

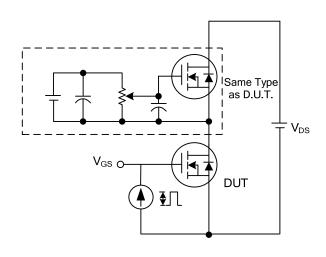
## **TEST CIRCUITS AND WAVEFORMS**

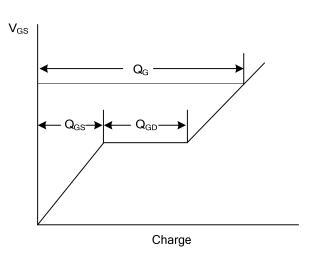


90% 10% t<sub>d(ON)</sub>

itching Test Circuit

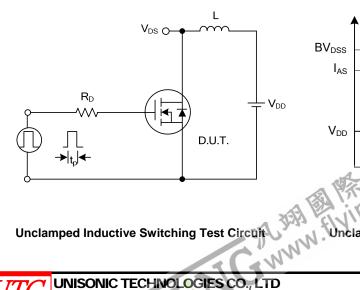
**Switching Waveforms** 

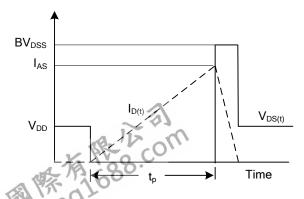




**Gate Charge Test Circuit** 

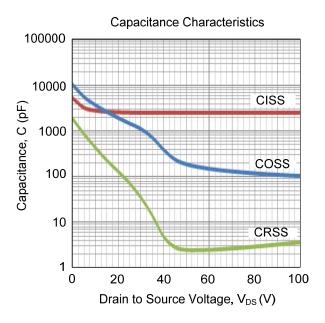
**Gate Charge Waveform** 





Unclamped Inductive Switching Waveforms

## ■ TYPICAL CHARACTERISTICS



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